

## 54ACQ374 • 54ACTQ374

### Quiet Series Octal D Flip-Flop with TRI-STATE® Outputs

#### General Description

The 'ACQ/ACTQ374 is a high-speed, low-power octal D-type flip-flop featuring separate D-type inputs for each flip-flop and TRI-STATE outputs for bus-oriented applications. A buffered Clock (CP) and Output Enable ( $\overline{OE}$ ) are common to all flip-flops.

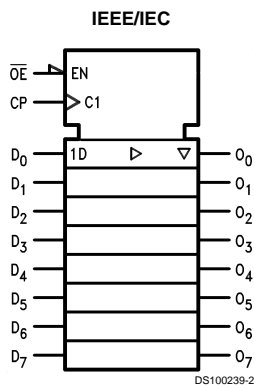
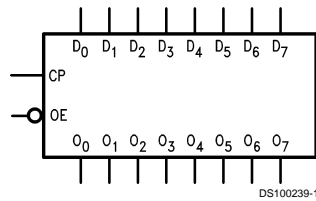
The 'ACQ/ACTQ374 utilizes Quiet Series technology to guarantee quiet output switching and improve dynamic threshold performance. FACT Quiet Series™ features GTO™ output control and undershoot corrector in addition to a split ground bus for superior performance.

- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Improved latch-up immunity
- Buffered positive edge-triggered clock
- TRI-STATE outputs drive bus lines or buffer memory address registers
- Outputs source/sink 24 mA
- Faster prop delays than the standard 'AC/ACT374
- 4 kV minimum ESD immunity
- Standard Military Drawing (SMD)
  - 'ACTQ374: 5962-92189
  - 'ACQ374: 5962-92179

#### Features

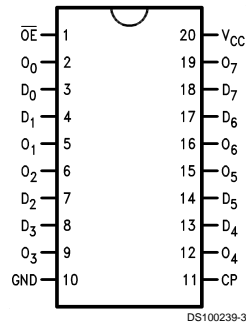
- $I_{CC}$  and  $I_{OZ}$  reduced by 50%

#### Logic Symbols

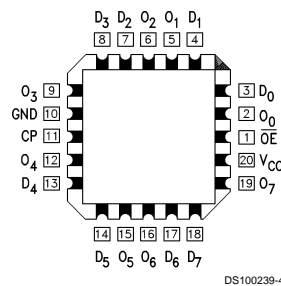


#### Connection Diagrams

Pin Assignment for DIP and Flatpak



Pin Assignment for LCC



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 FACT® is a registered trademark of Fairchild Semiconductor Corporation.  
 FACT Quiet Series™ is a trademark of Fairchild Semiconductor Corporation.

## Connection Diagrams (Continued)

Pin Names	Description
D <sub>0</sub> -D <sub>7</sub>	Data Inputs
CP	Clock Pulse Input
$\overline{OE}$	TRI-STATE Output Enable Input
O <sub>0</sub> -O <sub>7</sub>	TRI-STATE Outputs

### Functional Description

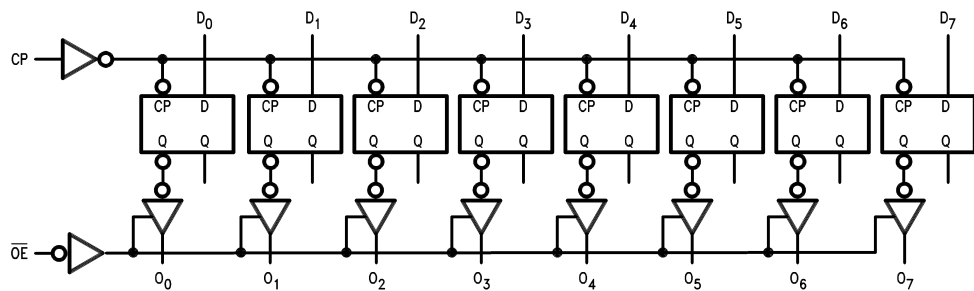
The 'ACQ/ACTQ374 consists of eight edge-triggered flip-flops with individual D-type inputs and TRI-STATE true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable ( $\overline{OE}$ ) LOW, the contents of the eight flip-flops are available at the outputs. When the  $\overline{OE}$  is HIGH, the outputs go to the high impedance state. Operation of the  $\overline{OE}$  input does not affect the state of the flip-flops.

### Truth Table

Inputs			Outputs
D <sub>n</sub>	CP	$\overline{OE}$	O <sub>n</sub>
H	↗	L	H
L	↗	L	L
X	X	H	Z

H = HIGH Voltage Level  
 L = LOW Voltage Level  
 X = Immaterial  
 Z = High Impedance  
 ↗ = LOW-to-HIGH Transition

### Logic Diagram



DS100239-5

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ )	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage ( $V_I$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current ( $I_{OK}$ )	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage ( $V_O$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current ( $I_O$ )	±50 mA
DC $V_{CC}$ or Ground Current per Output Pin ( $I_{CC}$ or $I_{GND}$ )	±50 mA
Storage Temperature ( $T_{STG}$ )	-65°C to +150°C
DC Latch-Up Source or Sink Current	±300 mA
Junction Temperature ( $T_J$ )	
CDIP	175°C

## Recommended Operating Conditions

Supply Voltage ( $V_{CC}$ )	
'ACQ	2.0V to 6.0V
'ACTQ	4.5V to 5.5V
Input Voltage ( $V_I$ )	0V to $V_{CC}$
Output Voltage ( $V_O$ )	0V to $V_{CC}$
Operating Temperature ( $T_A$ )	
54ACQ/ACTQ	-55°C to +125°C
Minimum Input Edge Rate $\Delta V/\Delta t$	
'ACQ Devices	
$V_{IN}$ from 30% to 70% of $V_{CC}$	
$V_{CC}$ @ 3.0V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate $\Delta V/\Delta t$	
'ACTQ devices	
$V_{IN}$ from 0.8V to 2.0V	
$V_{CC}$ @ 4.5V, 5.5V	125 mV/ns

**Note 1:** Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT® circuits outside databook specifications.

**Note 2:** All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from -40°C to +125°C.

## DC Characteristics for 'ACQ Family Devices

Symbol	Parameter	$V_{CC}$ (V)	54ACQ		Units	Conditions
			$T_A = -55^\circ\text{C to } +125^\circ\text{C}$			
			Guaranteed Limits			
$V_{IH}$	Minimum High Level Input Voltage	3.0	2.1		V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	3.15			
		5.5	3.85			
$V_{IL}$	Maximum Low Level Input Voltage	3.0	0.9		V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	1.35			
		5.5	1.65			
$V_{OH}$	Minimum High Level Output Voltage	3.0	2.9		V	$I_{OUT} = -50 \mu A$
		4.5	4.4			
		5.5	5.4			
$V_{OL}$	Maximum Low Level Output Voltage	3.0	2.4		V	(Note 3) $V_{IN} = V_{IL}$ or $V_{IH}$ $I_{OH} = -12 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ $I_{OH} = -24 \text{ mA}$
		4.5	3.7			
		5.5	4.7			
$V_{OL}$	Maximum Low Level Output Voltage	3.0	0.1		V	$I_{OUT} = 50 \mu A$
		4.5	0.1			
		5.5	0.1			
$V_{OL}$	Maximum Low Level Output Voltage	3.0	0.50		V	(Note 3) $I_{OL} = 12 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 24 \text{ mA}$
		4.5	0.50			
		5.5	0.50			
$I_{IN}$	Maximum Input Leakage Current	5.5	±1.0		μA	$V_I = V_{CC}, GND$ (Note 5)
$I_{OLD}$	(Note 4) Minimum Dynamic Output Current	5.5	50		mA	$V_{OLD} = 1.65V \text{ Max}$
$I_{OHD}$		5.5	-50		mA	$V_{OHD} = 3.85V \text{ Min}$

### DC Characteristics for 'ACQ Family Devices (Continued)

Symbol	Parameter	V <sub>CC</sub> (V)	54ACQ		Units	Conditions
			T <sub>A</sub> = -55°C to +125°C			
			Guaranteed Limits			
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5	80.0		μA	V <sub>IN</sub> = V <sub>CC</sub> or GND (Note 5)
I <sub>OZ</sub>	Maximum TRI-STATE Leakage Current	5.5	±5.0		μA	V <sub>I(OE)</sub> = V <sub>IL</sub> , V <sub>IH</sub> V <sub>I</sub> = V <sub>CC</sub> , GND V <sub>O</sub> = V <sub>CC</sub> , GND
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>	5.0	1.5		V	(Notes 6, 7)
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>	5.0	-1.2		V	(Notes 6, 7)

**Note 3:** All outputs loaded; thresholds on input associated with output under test.

**Note 4:** Maximum test duration 2.0 ms, one output loaded at a time.

**Note 5:** I<sub>IN</sub> and I<sub>CC</sub> @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.

I<sub>CC</sub> for 54ACQ @ 25°C is identical to 74ACQ @ 25°C.

**Note 6:** Plastic DIP Package.

**Note 7:** Max number of outputs defined as (n). Data inputs are driven 0V to 5V. One output @ GND.

**Note 8:** Max number of data inputs (n) switching. (n-1) inputs switching 0V to 5V ('ACQ). Input-under-test switching: 5V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f = 1 MHz.

### DC Characteristics for 'ACTQ Family Devices

Symbol	Parameter	V <sub>CC</sub> (V)	54ACTQ		Units	Conditions
			T <sub>A</sub> = -55°C to +125°C			
			Guaranteed Limits			
V <sub>IH</sub>	Minimum High Level Input Voltage	4.5	2.0		V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
		5.5	2.0			
V <sub>IL</sub>	Maximum Low Level Input Voltage	4.5	0.8		V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
		5.5	0.8			
V <sub>OH</sub>	Minimum High Level Output Voltage	4.5	4.4		V	I <sub>OUT</sub> = -50 μA
		5.5	5.4			
		4.5	3.70		V	(Note 9) V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> I <sub>OH</sub> = -24 mA
		5.5	4.70			
V <sub>OL</sub>	Maximum Low Level Output Voltage	4.5	0.1		V	I <sub>OUT</sub> = 50 μA
		5.5	0.1			
		4.5	0.50		V	(Note 9) V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> I <sub>OL</sub> = 24 mA
		5.5	0.50			
I <sub>IN</sub>	Maximum Input Leakage Current	5.5	±1.0		μA	V <sub>I</sub> = V <sub>CC</sub> , GND
I <sub>OZ</sub>	Maximum TRI-STATE Current	5.5	±5.0		μA	V <sub>I</sub> = V <sub>IL</sub> , V <sub>IH</sub> V <sub>O</sub> = V <sub>CC</sub> , GND
I <sub>CC(T)</sub>	Maximum I <sub>CC</sub> /Input	5.5	1.6		mA	V <sub>I</sub> = V <sub>CC</sub> - 2.1V
I <sub>OLD</sub>	(Note 9) Minimum Dynamic Output Current	5.5	50		mA	V <sub>OLD</sub> = 1.65V Max
I <sub>OHD</sub>		5.5	-50		mA	V <sub>OHD</sub> = 3.85V Min

## DC Characteristics for 'ACTQ Family Devices (Continued)

Symbol	Parameter	V <sub>CC</sub> (V)	54ACTQ		Units	Conditions
			T <sub>A</sub> = -55°C to +125°C			
			Guaranteed Limits			
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5	80.0		μA	V <sub>IN</sub> = V <sub>CC</sub> or GND (Note 11)
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>	5.0	1.5		V	(Notes 12, 13)
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>	5.0	-1.2		V	(Notes 12, 13)

**Note 9:** All outputs loaded; thresholds on input associated with output under test.

**Note 10:** Maximum test duration 2.0 ms, one output loaded at a time.

**Note 11:** I<sub>CC</sub> for 54ACTQ @ 25°C is identical to 74ACTQ @ 25°C.

**Note 12:** Plastic DIP package.

**Note 13:** Max number of outputs defined as (n). Data inputs are driven 0V to 3V. One output @ GND

**Note 14:** Max number of data inputs (n) switching. (n-1) inputs switching 0V to 3V ('ACTQ). Input-under-test switching: 3V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f = 1 MHz.

## AC Electrical Characteristics

Symbol	Parameter	V <sub>CC</sub> (V) (Note 15)	54ACQ		Units	Fig. No.
			T <sub>A</sub> = -55°C to +125°C			
			C <sub>L</sub> = 50 pF			
			Min	Max		
f <sub>max</sub>	Maximum Clock Frequency	3.3	95		MHz	
		5.0	95			
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay CP to O <sub>n</sub>	3.3	1.0	16.5	ns	
		5.0	1.0	11.0		
t <sub>PZL</sub> , t <sub>PZH</sub>	Output Enable Time	3.3	1.0	16.5	ns	
		5.0	1.0	11.5		
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Output Disable Time	3.3	1.0	12.0	ns	
		5.0	1.0	10.5		

**Note 15:** Voltage Range 5.0 is 5.0V ±0.5V

Voltage Range 3.3 is 3.3V ±0.3V

## AC Operating Requirements

Symbol	Parameter	V <sub>CC</sub> (V) (Note 16)	54ACQ		Units	Fig. No.
			T <sub>A</sub> = -55°C to +125°C			
			C <sub>L</sub> = 50 pF			
			Guaranteed Minimum			
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to CP	3.3	3.0		ns	
		5.0	3.0			
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to CP	3.3	2.0		ns	
		5.0	1.5			
t <sub>w</sub>	CP Pulse Width, HIGH or LOW	3.3	5.0		ns	
		5.0	5.0			

**Note 16:** Voltage Range 5.0 is 5.0V ±0.5V

Voltage Range 3.3 is 3.3V ±0.3V

## AC Electrical Characteristics

Symbol	Parameter	V <sub>CC</sub> (V) (Note 17)	54ACTQ		Units	Fig. No.
			T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF			
			Min	Max		
f <sub>max</sub>	Maximum Clock Frequency	5.0	95		MHz	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay CP to O <sub>n</sub>	5.0	2.0	11.5	ns	
t <sub>PZL</sub> , t <sub>PZH</sub>	Output Enable Time	5.0	2.0	11.5	ns	
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Output Disable Time	5.0	1.5	10.5	ns	

Note 17: Voltage Range 5.0 is 5.0V ±0.5V

## AC Operating Requirements

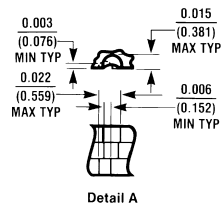
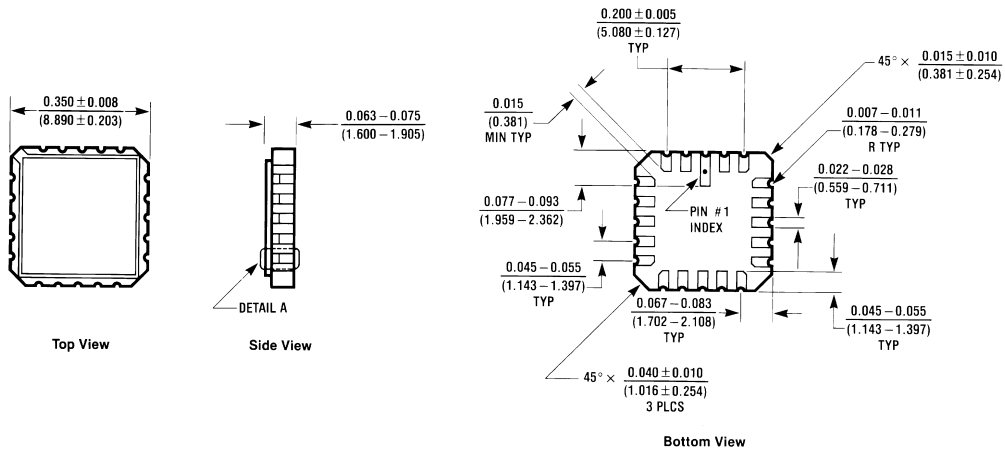
Symbol	Parameter	V <sub>CC</sub> (V) (Note 18)	54ACTQ		Units	Fig. No.
			T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF			
			Guaranteed Minimum			
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to CP	5.0	3.5		ns	
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to CP	5.0	2.0		ns	
t <sub>w</sub>	CP Pulse Width, HIGH or LOW	5.0	5.0		ns	

Note 18: Voltage Range 5.0 is 5.0V ±0.5V

## Capacitance

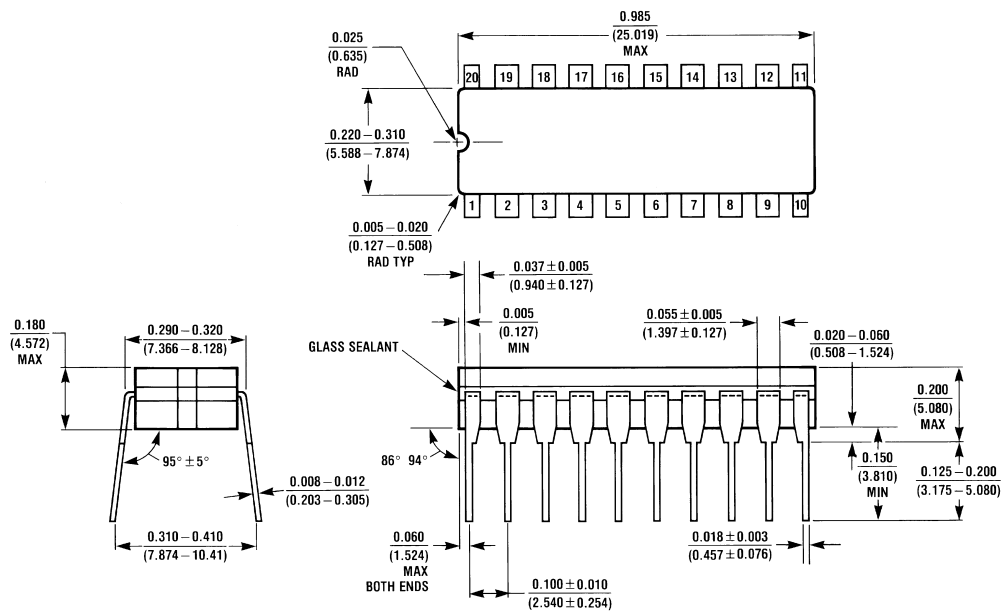
Symbol	Parameter	Typ	Units	Conditions
C <sub>IN</sub>	Input Capacitance	4.5	pF	V <sub>CC</sub> = OPEN
C <sub>PD</sub>	Power Dissipation Capacitance	42.0	pF	V <sub>CC</sub> = 5.0V

**Physical Dimensions** inches (millimeters) unless otherwise noted



E20A (REV D)

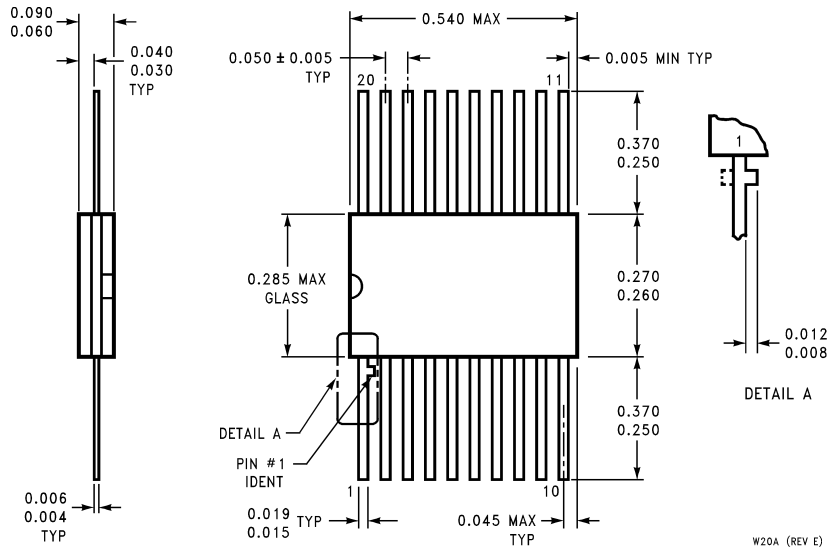
**20-Terminal Ceramic Leadless Chip Carrier (L)**  
NS Package Number E20A



J20A (REV M)

**20-Lead Ceramic Dual-In-Line Package (D)**  
NS Package Number J20A

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**20-Lead Ceramic Flatpak (F)  
NS Package Number W20A**

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